



























## Exams for group M18-416

Mon, 16 Dec	16:15 — 17:50	TEST	Law and Economics of Scientific Projects and Units  Nurahov N.N.  B-208
Mon, 23 Dec	12:00 — 15:00	TEST	Legal and International Aspects of Nonproliferation and Nuclear Materials Safety.  Krasnoborodko A.A., Kulikov E.G., Glebov V.B.  402
Mon, 23 Dec	15:00 — 18:00	TEST	Principles of Nuclear Technologies  Apse V.A.  402
Tue, 24 Dec	08:30 — 10:05	ATT	Reliability and Radiation Resistance of Microelectronic Devices and Systems  Zebrev G.I.  D-303
Tue, 24 Dec	10:15 — 11:50	ATT	Modern Micro and Nanotechnologies  Veselov D.S.  D-418
Wed, 25 Dec	10:15 — 11:50	ATT	Computer Technology: Design and Programming of Microprocessor Systems  Mokretsov M.O.  D-408
Thu, 26 Dec	10:15 — 11:50	ATT	Design of Integrated Circuits and Systems-on-Chip (SOC)  Bakerenkov A.S.  D-407
Thu, 26 Dec	12:45 — 14:20	TEST	Computer Technology  Krasavin A.V.  V-117
Fri, 27 Dec	10:15 — 11:50	TEST	Practical Training (Research Work)  Samotaev N.N.  dep.27
Fri, 10 Jan	09:00 — 13:00	EXAM	Computer Technology: Design and Programming of Microprocessor Systems  Mokretsov M.O.  D-408
Tue, 14 Jan	09:00 — 13:00	EXAM	Reliability and Radiation Resistance of Microelectronic Devices and Systems  Zebrev G.I.  D-303
Mon, 20 Jan	09:00 — 13:00	EXAM	Design of Integrated Circuits and Systems-on-Chip (SOC)  Bakerenkov A.S.  D-408
Fri, 24 Jan	09:00 — 13:00	EXAM	Modern Micro and Nanotechnologies  Veselov D.S.  D-418